

Replaces DS5867-1.1

DIM800FSS12-A000

Single Switch IGBT Module

DS5867-2 November 2010 (LN27709)

FEATURES

- 10µs Short Circuit Withstand
- Non Punch Through Silicon
- Isolated Cu Base with Al₂O₃ Substrates
- Lead Free construction

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800FSS12-A000 is a single switch 1200V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

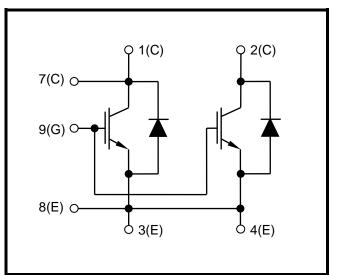
DIM800FSS12-A000

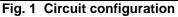
Note: When ordering, please use the complete part number

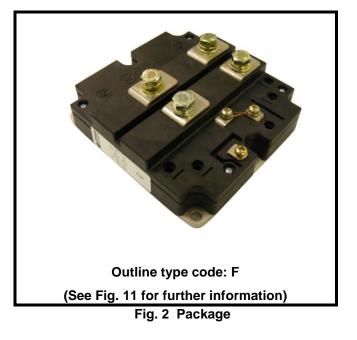
KEY PARAMETERS

V _{CES}		1200V
V _{CE(sat)} *	ʻ (typ)	2.2V
I _C	(max)	800A
I _{C(РК)}	(max)	1600A

* Measured at the power busbars, not the auxiliary terminals







ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	1200	V
V_{GES}	Gate-emitter voltage		±20	V
Ι _C	Continuous collector current	$T_{case} = 85^{\circ}C$	800	А
I _{C(PK)}	Peak collector current	1ms, T _{case} = 115°C	1600	А
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_j = 150^{\circ}C$	6940	W
l ² t	Diode I ² t value	$V_R = 0, t_p = 10ms, T_j = 125^{o}C$	100	kA ² s
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V

THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AI_2O_3
Baseplate material:	Cu
Creepage distance:	20mm
Clearance:	10mm
CTI (Comparative Tracking Index):	350

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	18	°C/kW
R _{th(j-c)}	Thermal resistance – diode	Continuous dissipation - junction to case	-	-	40	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	8	°C/kW
T _j Ju	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
5	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
		$V_{GE} = 0V, V_{CE} = V_{CES}$			1	mA
I _{CES}	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$			25	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			4	μA
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_{C} = 80 \text{mA}, V_{GE} = V_{CE}$	4.5	5.5	6.5	V
v †	Collector-emitter	V _{GE} = 15V, I _C = 800A		2.2	2.8	V
$V_{CE(sat)}^{\dagger}$	saturation voltage	$V_{GE} = 15V, I_C = 800A, T_j = 125^{\circ}C$		2.6	3.2	V
I _F	Diode forward current	DC			800	А
I _{FM}	Diode maximum forward current	t _p = 1ms			1600	А
+	V _F [†] Diode forward voltage	I _F = 800A		2.1	2.4	V
VF		I _F = 800A, T _j = 125°C		2.1	2.4	V
C _{ies}	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		90		nF
Qg	Gate charge	±15V		9		μC
C _{res}	Reverse transfer capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$				nF
L _M	Module inductance			20		nH
R _{INT}	Internal resistance			270		μΩ
SC _{Data}	Short circuit current, I _{SC}	$\begin{split} T_{j} &= 125^{\circ}C, \ V_{CC} = 900V \\ t_{p} &\leq 10 \mu s, \ V_{GE} \leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} x \ dI/dt \\ IEC \ 60747-9 \end{split}$		4500		A

Note:

 † Measured at the power busbars, not the auxiliary terminals * L is the circuit inductance + $L_{\rm M}$

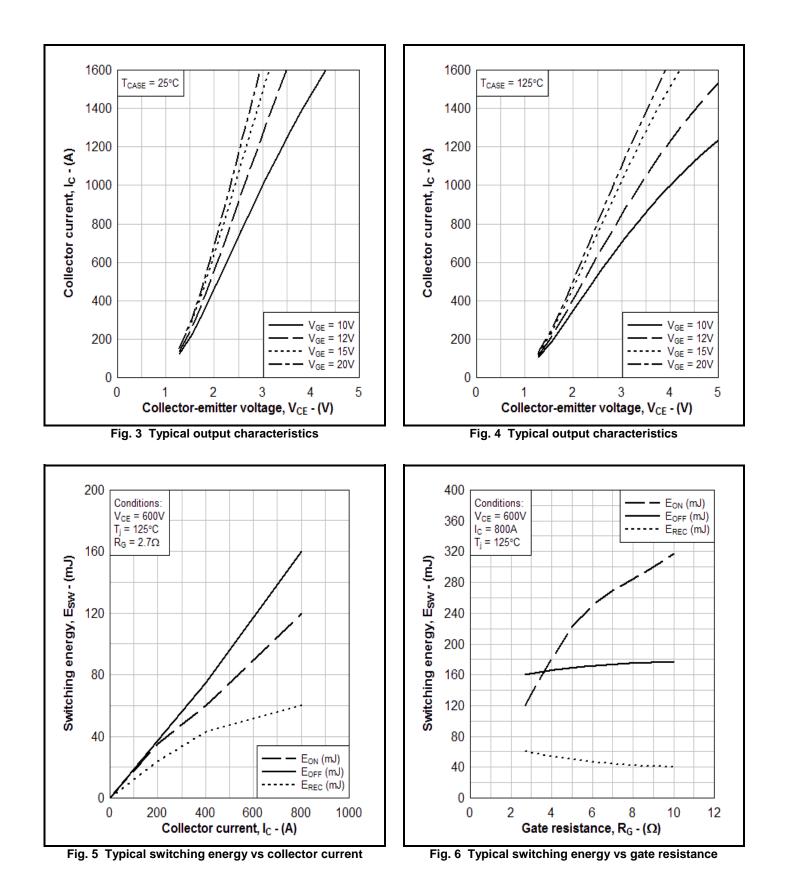
ELECTRICAL CHARACTERISTICS

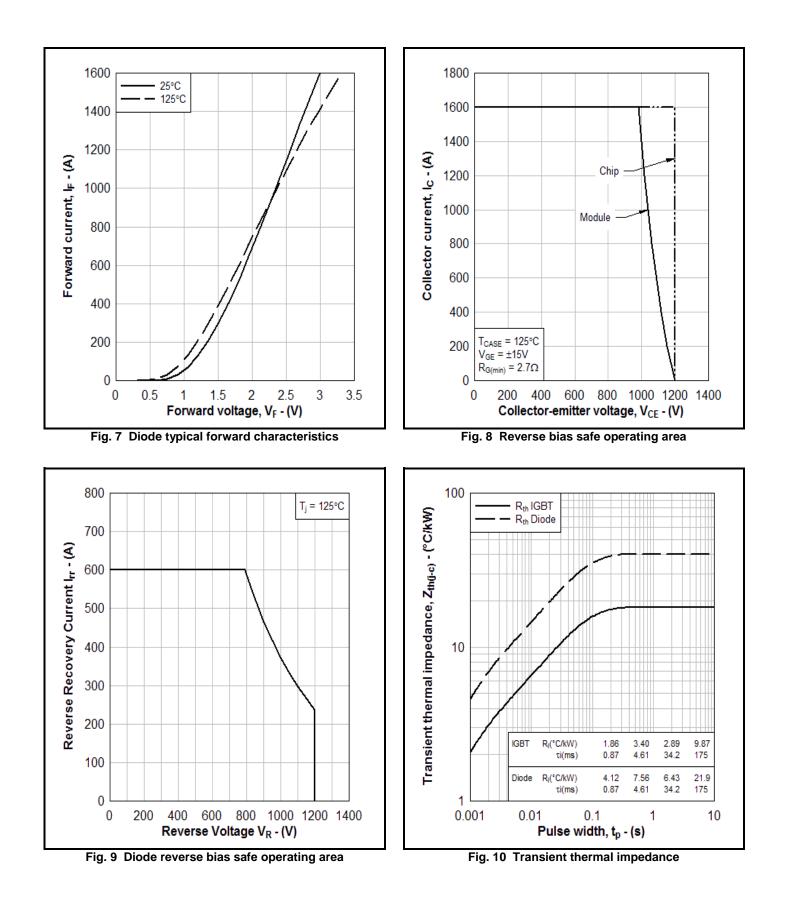
T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time			1250		ns
t _f	Fall time	$I_{\rm C} = 800 \text{A}$ $V_{\rm GF} = \pm 15 \text{V}$		170		ns
E _{OFF}	Turn-off energy loss	$V_{GE} = \pm 13V$ $V_{CE} = 600V$		130		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.7\Omega$		250		ns
t _r	Rise time	$R_{G(OFF)} = 2.7\Omega$ $L_{S} \sim 100 \text{nH}$		250		ns
E _{ON}	Turn-on energy loss	_3		80		mJ
Q _{rr}	Diode reverse recovery charge	I _F = 800A		80		μC
I _{rr}	Diode reverse recovery current	$V_{CE} = 600V$		380		А
E _{rec}	Diode reverse recovery energy	$dI_F/dt = 4200A/\mu s$		30		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time			1500		ns
t _f	Fall time	I _C = 800A V _{GE} = ±15V		200		ns
E _{OFF}	Turn-off energy loss	$V_{GE} = \pm 13V$ $V_{CE} = 600V$		160		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.7\Omega$		400		ns
t _r	Rise time	$R_{G(OFF)} = 2.7\Omega$ $L_{S} \sim 100 \text{nH}$		220		ns
E _{ON}	Turn-on energy loss			120		mJ
Q _{rr}	Diode reverse recovery charge	I _F = 800A		160		μC
Irr	Diode reverse recovery current	$V_{CE} = 600V$		450		А
E _{rec}	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		60		mJ



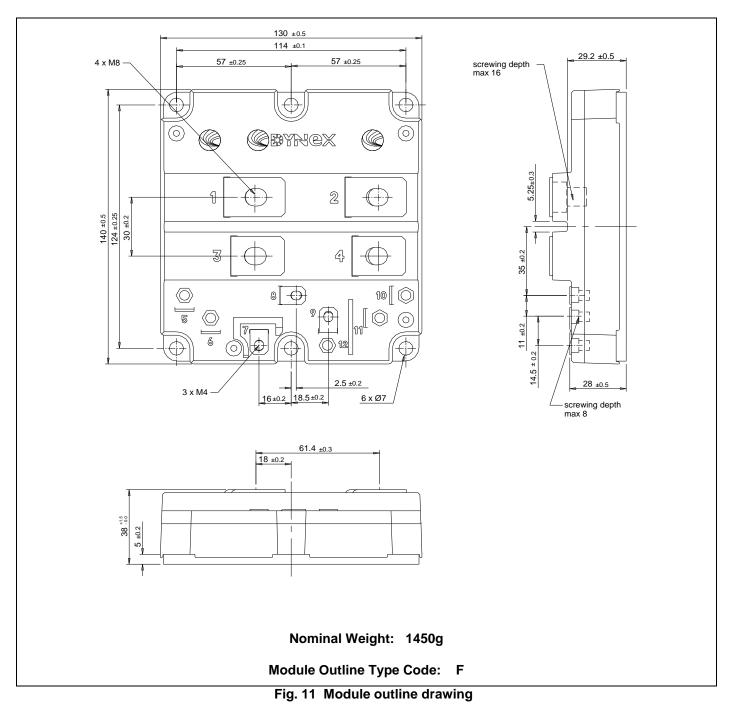


Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures.



PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.**



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